

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/549,282	<b>Applicant(s)/Patent under Reexamination</b> CHOI, KWAN-JUN
	<b>Examiner</b> Winnie Yip	<b>Art Unit</b> 3636

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner